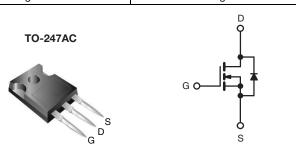


# **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	60	600			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.27			
Q <sub>g</sub> (Max.) (nC)	15	150			
Q <sub>gs</sub> (nC)	46	46			
Q <sub>gd</sub> (nC)	64	64			
Configuration	Sing	Single			



#### N-Channel MOSFET

## **FEATURES**

• Superfast Body Diode Eliminates the Need for External Diodes in ZVS Applications



 Lower Gate Charge Results in Simple Drive RoHS Requirements

- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise **Immunity**
- Compliant to RoHS Directive 2002/95/EC

## **APPLICATIONS**

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free	IRFP21N60LPbF
Lead (PD)-Iree	SiHFP21N60L-E3
SnPb	IRFP21N60L
SHED	SiHFP21N60L

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	600	V
Gate-Source Voltage			$V_{GS}$	± 30	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C		21	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	13	A
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	84	
Linear Derating Factor				2.6	W/°C
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	420	mJ
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	21	Α
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	33	mJ
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	330	W
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	16	V/ns
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	- °C
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>	7
Mounting Torque 6-32 or M3 screw		12 corour		10	lbf ⋅ in
Mounting Torque	6-32 or M3 screw			1.1	N⋅m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T<sub>J</sub> = 25 °C, L = 1.9 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 21 A, dV/dt = 11 V/ns (see fig. 12a). c. I<sub>SD</sub>  $\leq$  21 A, dI/dt  $\leq$  530 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C.

- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP21N60L, SiHFP21N60L



THERMAL RESISTANCE RATINGS						
PARAMETER	PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.38			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> = 250 μA	600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I <sub>D</sub> = 1 mA	-	420	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> :	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	l	V <sub>DS</sub> =	$= 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	-	-	50	μΑ
Zero date voltage Drain Gurrent	I <sub>DSS</sub>	V <sub>DS</sub> = 480 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	2.0	mA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 13 A^b$	-	0.27	0.32	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS}$	= 50 V, I <sub>D</sub> = 13 A	11	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	4000	-	
Output Capacitance	$C_{oss}$		$V_{DS} = 25 V,$	-	340	-	
Reverse Transfer Capacitance	$C_{rss}$	f = 1	.0 MHz, see fig. 5	-	29	-	pF
Effective Output Capacitance	Coss eff.	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 V to 480 V <sup>c</sup>		-	170	-	- Pi
Effective Output Capacitance (Energy Related)	C <sub>oss</sub> eff. (ER)			-	130	-	
Total Gate Charge	$Q_g$		1 04 4 1/ 400 1/	-	-	150	
Gate-Source Charge	$Q_{gs}$	$V_{GS} = 10 \text{ V}$ $I_D = 21 \text{ A}, V_{DS} = 480 \text{ V}$ see fig. 7 and 15 <sup>b</sup>		-	-	46	nC
Gate-Drain Charge	$Q_{gd}$		3	-	-	64	
Gate Resistance	$R_g$	f = 1	MHz, open drain	-	0.63	-	Ω
Turn-On Delay Time	t <sub>d(on)</sub>	.,	000 \ / \ 01 \ \		20	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 300 \text{ V}, I_D = 21 \text{ A},$		-	58	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	9	1.3 $\Omega$ , $V_{GS} = 10 \text{ V}$ ,	-	33	-	
Fall Time	t <sub>f</sub>	see fig. 11a and 11b <sup>b</sup>		-	10	-	
<b>Drain-Source Body Diode Characteristic</b>	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	21	_ A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	84	A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 21 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.5	V
		T <sub>J</sub> = 25 °C, I <sub>F</sub> = 21 A		-	160	240	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 125 °C, dl/dt = 100 A/μs <sup>b</sup>		-	400	610	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 21 A, V <sub>GS</sub> = 0 V <sup>b</sup>			480	730	nC
Body Blode Neverse necovery Orlange	<b>∨</b> rr	T <sub>J</sub> = 125 °C, dl/dt = 100 A/μs <sup>b</sup>		-	1540	2310	110
Reverse Recovery Time	I <sub>RRM</sub>	T <sub>J</sub> = 25 °C		-	5.3	7.9	Α
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )			1 _\		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising form 0 % to 80 %  $V_{DS}$ .  $C_{oss}$  eff. (ER) is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

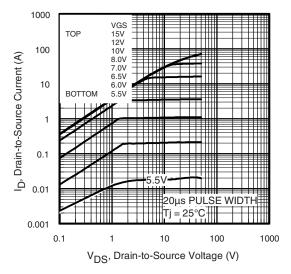


Fig. 1 - Typical Output Characteristics

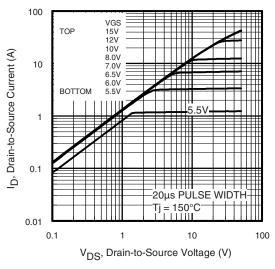


Fig. 2 - Typical Output Characteristics

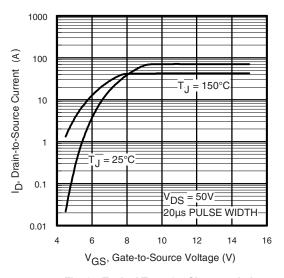


Fig. 3 - Typical Transfer Characteristics

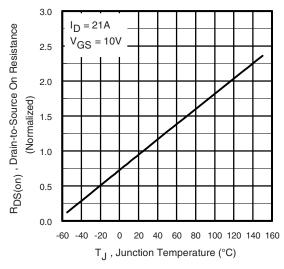


Fig. 4 - Normalized On-Resistance vs. Temperature



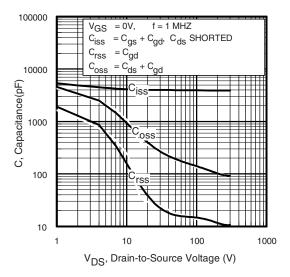


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

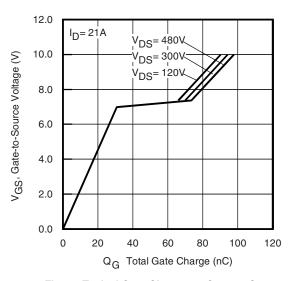


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

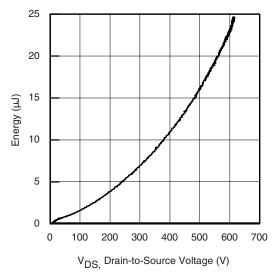


Fig. 6 - Typical Output Capacitance Stored Energy vs. V<sub>DS</sub>

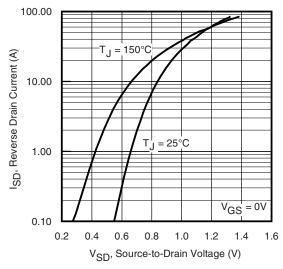
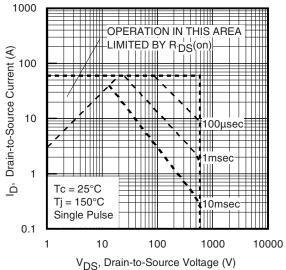


Fig. 8 - Typical Source-Drain Diode Forward Voltage





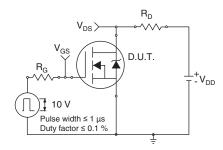
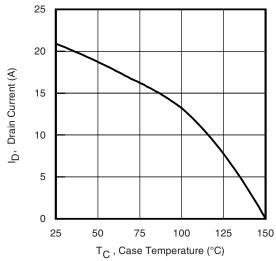


Fig. 11a - Switching Time Test Circuit





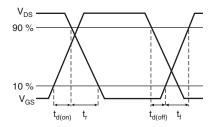


Fig. 11b - Switching Time Waveforms

Fig. 10 - Maximum Drain Current vs. Case Temperature

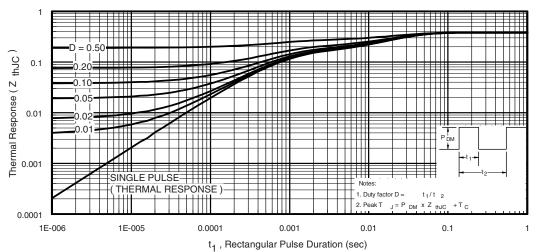


Fig. 12 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



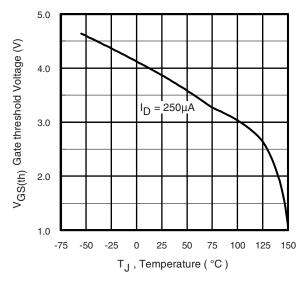


Fig. 13 - Threshold Voltage vs. Temperature

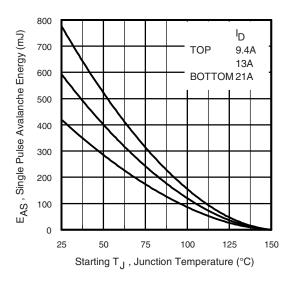


Fig. 14a - Maximum Avalanche Energy vs. Drain Current

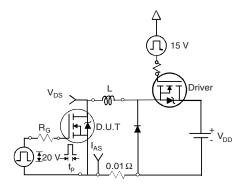


Fig. 14b - Unclamped Inductive Test Circuit

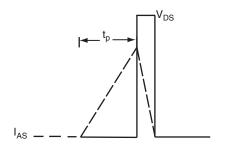


Fig. 14c - Unclamped Inductive Waveforms

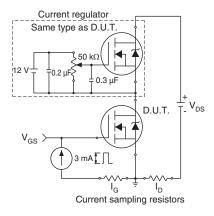


Fig. 15a - Gate Charge Test Circuit

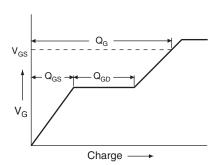
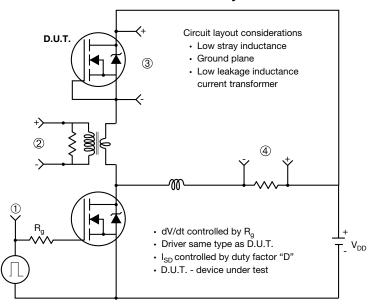


Fig. 15b - Basic Gate Charge Waveform

#### Peak Diode Recovery dV/dt Test Circuit



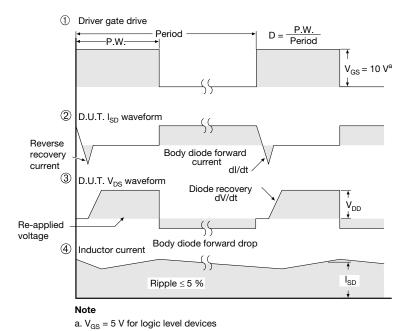


Fig. 16 - For N-Channel

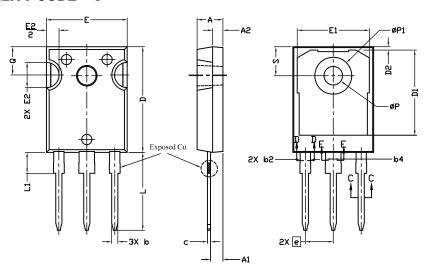
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Document Number: 91206 S11-0446-Rev. C, 14-Mar-11

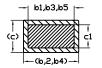


# **TO-247AC (High Voltage)**

## **VERSION 1: FACILITY CODE = 9**







Section C--C,D--D,E--E

	MILLIN	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.83	5.21	
A1	2.29	2.55	
A2	1.50	2.49	
b	1.12	1.33	
b1	1.12	1.28	
b2	1.91	2.39	6
b3	1.91	2.34	
b4	2.87	3.22	6, 8
b5	2.87	3.18	
С	0.55	0.69	6
c1	0.55	0.65	
D	20.40	20.70	4

	MILLIN		
DIM.	MIN.	MAX.	NOTES
D1	16.25	16.85	5
D2	0.56	0.76	
E	15.50	15.87	4
E1	13.46	14.16	5
E2	4.52	5.49	3
е	5.44	BSC	
L	14.90	15.40	
L1	3.96	4.16	6
ØР	3.56	3.65	7
Ø P1	7.19		
Q	5.31	5.69	
S	5.54	5.74	

#### Notes

- (1) Package reference: JEDEC TO247, variation AC
- (2) All dimensions are in mm
- (3) Slot required, notch may be rounded
- (4) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outermost extremes of the plastic body
- (5) Thermal pad contour optional with dimensions D1 and E1
- (6) Lead finish uncontrolled in L1
- (7) Ø P to have a maximum draft angle of 1.5° to the top of the part with a maximum hole diameter of 3.91 mm
- (8) Dimension b2 and b4 does not include dambar protrusion. Allowable dambar protrusion shall be 0.1 mm total in excess of b2 and b4 dimension at maximum material condition

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## **VERSION 2: FACILITY CODE = Y**



	MILLIN	IETERS	
DIM.	MIN.	MAX.	NOTES
Α	4.58	5.31	
A1	2.21	2.59	
A2	1.17	2.49	
b	0.99	1.40	
b1	0.99	1.35	
b2	1.53	2.39	
b3	1.65	2.37	
b4	2.42	3.43	
b5	2.59	3.38	
С	0.38	0.86	
c1	0.38	0.76	
D	19.71	20.82	
D1	13.08	-	

	MILLIN		
DIM.	MIN.	MAX.	NOTES
D2	0.51	1.30	
E	15.29	15.87	
E1	13.72	-	
е	5.46	BSC	
Øk	0.2	254	
L	14.20	16.25	
L1	3.71	4.29	
ØΡ	3.51	3.66	
Ø P1	-	7.39	
Q	5.31	5.69	
R	4.52	5.49	
S	5.51	BSC	
	•		

ECN: E19-0614-Rev. E, 25-Nov-2019

DWG: 5971

## Notes

- (1) Dimensioning and tolerancing per ASME Y14.5M-1994
- (2) Contour of slot optional
- (3) Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body
- (4) Thermal pad contour optional with dimensions D1 and E1
- (5) Lead finish uncontrolled in L1
- (6) Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154")
- (7) Outline conforms to JEDEC outline TO-247 with exception of dimension c
- (8) Xian and Mingxin actually photo



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